## Notice of References Cited Application/Control No. 09/497,051 Examiner Timothy J Henn Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,249,643	06-2001	Mimura, Toshihiko	386/107
*	В	US-5,576,763	11-1996	Ackland et al.	348/308
*	С	US-4,542,409	09-1985	Ochi, Shigeharu	348/281
	D	US-			
-	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	t	US-			
	J.	ųs-			
	К	US-			1
	L	· US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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